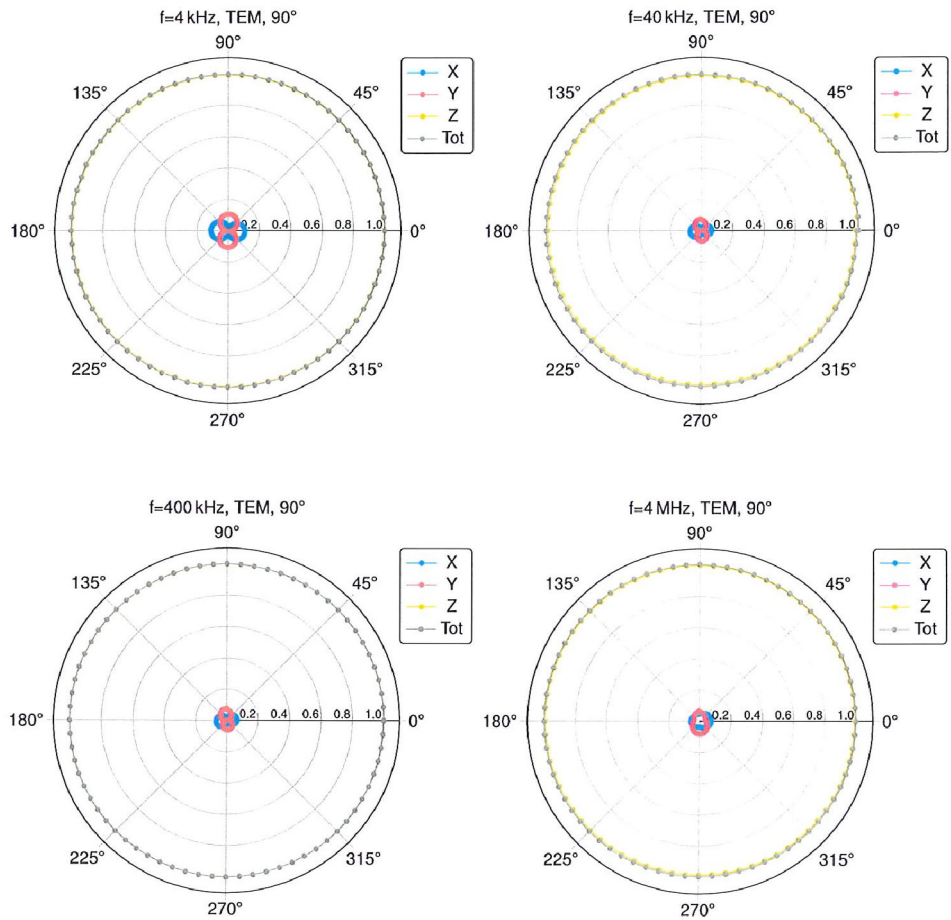
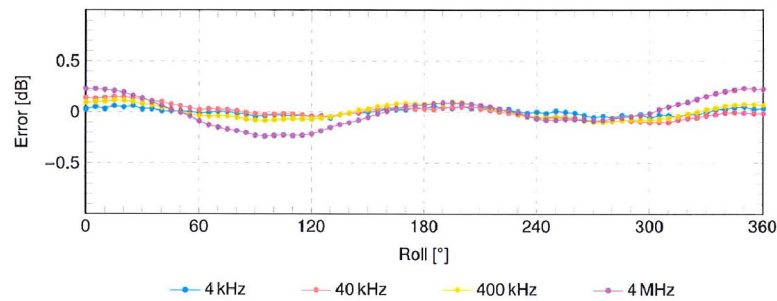


H-Field Receiving Pattern (ϕ), $\vartheta = 90^\circ$

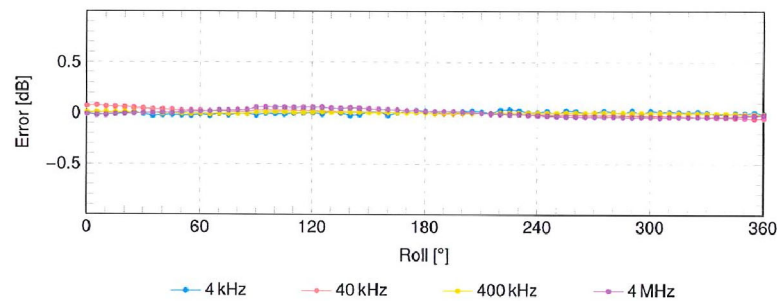


FCC ID: A3LSMS938JPN	 WPT RF EXPOSURE EVALUATION REPORT	Reviewed by: Technical Manager
Test Dates: 10/14/2024 – 11/1/2024	Apparatus/Device: Mobile Handset	APPENDIX C: Page 22 of 26

H-Field Receiving Pattern (ϕ), $\theta = 0^\circ$



H-Field Receiving Pattern (ϕ), $\theta = 90^\circ$



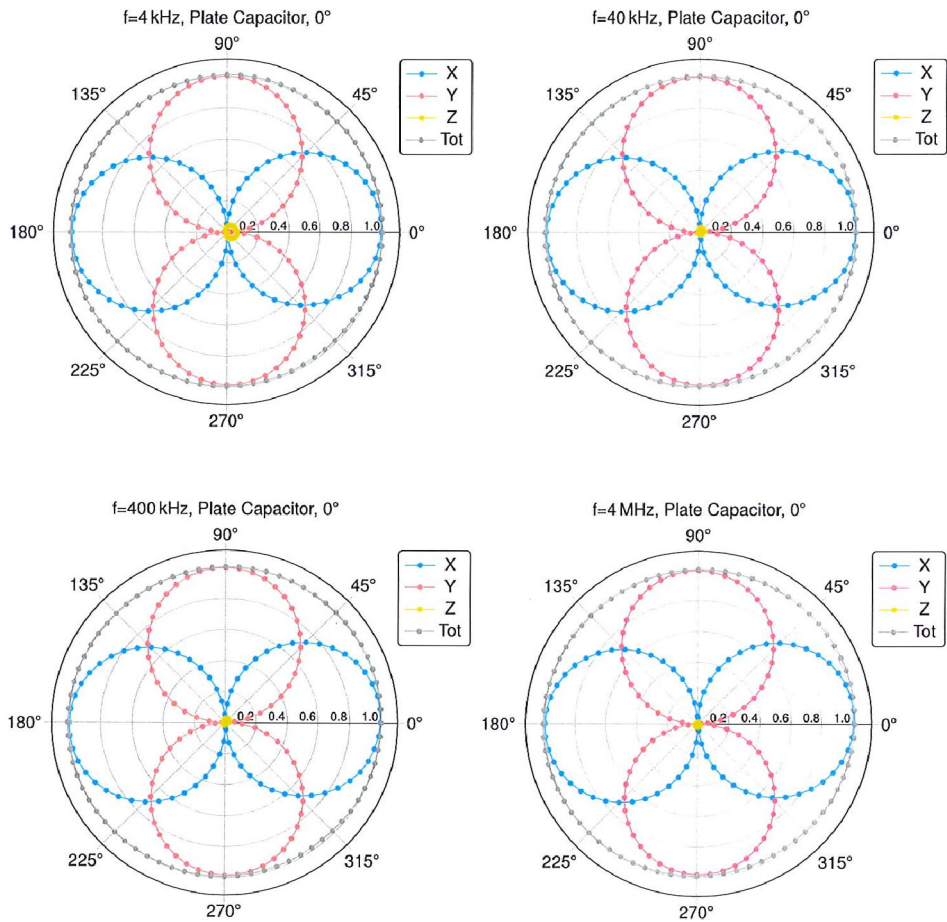
SPEAG axial deviation from the ideal response tolerance for H-field: ± 0.6 dB

FCC ID: A3LSMS938JPN	 WPT RF EXPOSURE EVALUATION REPORT	Reviewed by: Technical Manager
Test Dates: 10/14/2024 – 11/1/2024	Apparatus/Device: Mobile Handset	APPENDIX C: Page 23 of 26

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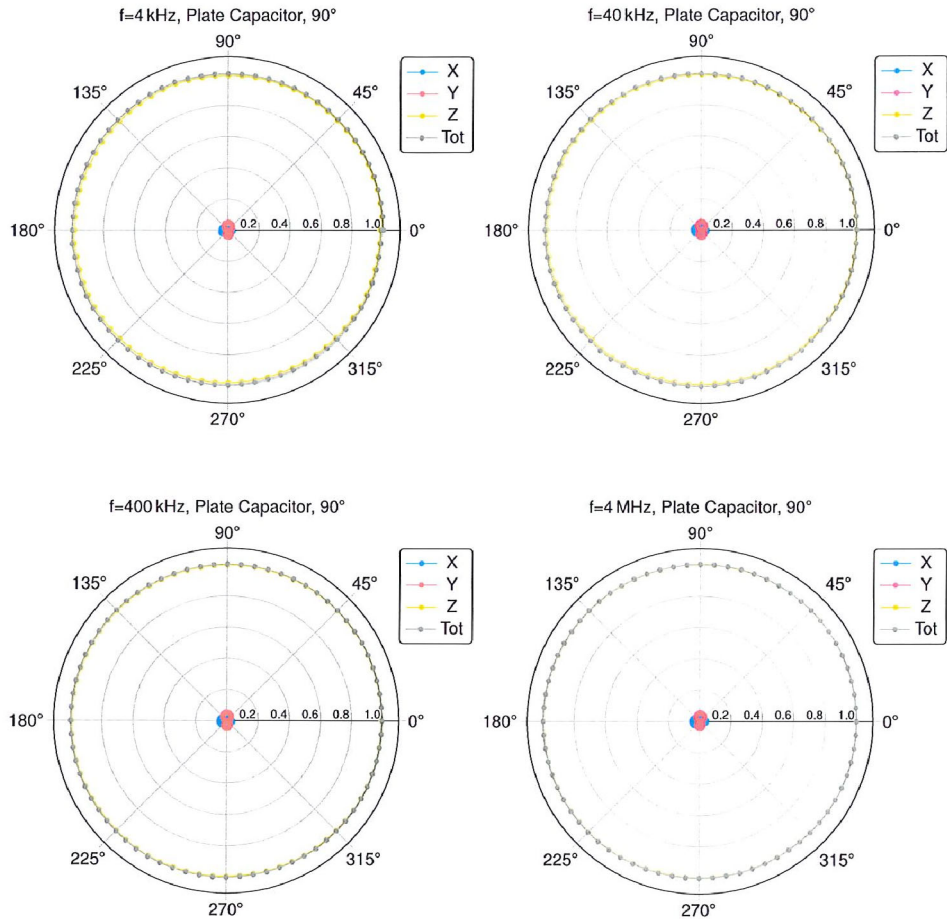
Isotropy E-Field

E-Field Receiving Pattern (ϕ), $\vartheta = 0^\circ$



FCC ID: A3LSMS938JPN	 WPT RF EXPOSURE EVALUATION REPORT	Reviewed by: Technical Manager
Test Dates: 10/14/2024 – 11/1/2024	Apparatus/Device: Mobile Handset	APPENDIX C: Page 24 of 26

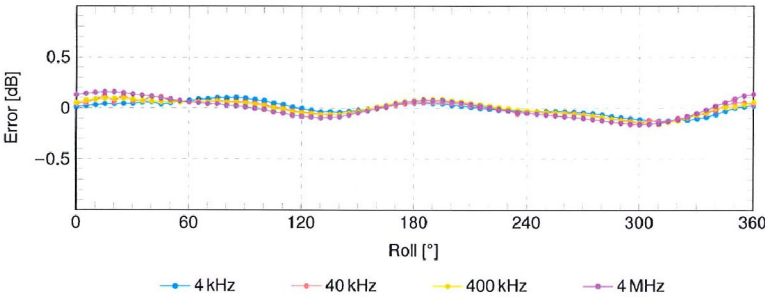
E-Field Receiving Pattern (ψ), $\vartheta = 90^\circ$



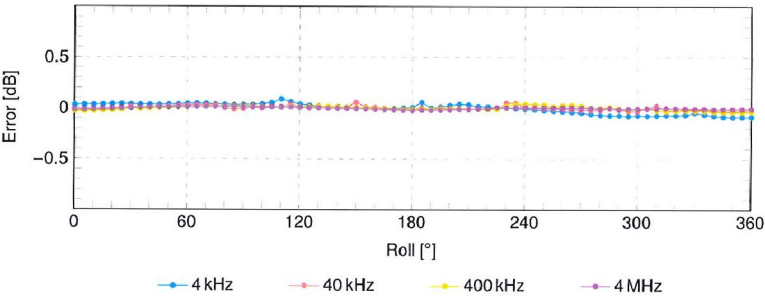
FCC ID: A3LSMS938JPN	 WPT RF EXPOSURE EVALUATION REPORT	Reviewed by: Technical Manager
Test Dates: 10/14/2024 – 11/1/2024	Apparatus/Device: Mobile Handset	APPENDIX C: Page 25 of 26

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E-Field Receiving Pattern (ϕ), $\vartheta = 0^\circ$



E-Field Receiving Pattern (ϕ), $\vartheta = 90^\circ$



SPEAG axial deviation from the ideal response tolerance for E-field: ± 0.8 dB

FCC ID: A3LSMS938JPN	 WPT RF EXPOSURE EVALUATION REPORT	Reviewed by: Technical Manager
Test Dates: 10/14/2024 – 11/1/2024	Apparatus/Device: Mobile Handset	APPENDIX C: Page 26 of 26

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